

10N60ZG-TF1-T-VB Datasheet N-Channel 650V (D-S) Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	650			
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.82		
Q _g max. (nC)	57			
Q _{gs} (nC)	4.0			
Q _{gd} (nC)	5.4			
Configuration	Single			

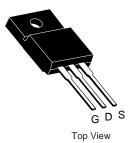
FEATURES

- Low figure-of-merit (FOM) $R_{\text{on}} \ x \ Q_{\text{g}}$
- Low input capacitance (C_{iss})
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_g)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
- Fluorescent ballast lighting
- Industrial

TO-220 FULLPAK



G C S

ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted) SYMBOL PARAMETER LIMIT UNIT Drain-Source Voltage 650 V_{DS} V ± 30 Gate-Source Voltage V_{GS} $T_C = 25 \ ^{\circ}C$ 10 Continuous Drain Current (T_{.1} = 150 °C) V_{GS} at 10 V I_{D} T_C = 100 °C 8 А Pulsed Drain Current a I_{DM} 35 1.67/1.5/0.3 Linear Derating Factor W/°C Single Pulse Avalanche Energy b E_{AS} 86 mJ Maximum Power Dissipation 178/156/53 W P_D Operating Junction and Storage Temperature Range -55 to +150 °C T_J, T_{stq} Drain-Source Voltage Slope T_J = 125 °C 50 dV/dt V/ns Reverse Diode dV/dt d 4.5 Soldering Recommendations (Peak Temperature) ^c °C for 10 s 300

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 28.2 mH, $R_g = 25 \Omega$, $I_{AS} = 3.5$ A.

c. 1.6 mm from case. d. $I_{SD} \leq I_D$, dI/dt = 100 A/µs, starting T_J = 25 °C.

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WV	vw.\	/Bs	em	i.con	l

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	63	°C/W
Maximum Junction-to-Case (Drain)	R _{th-IC}	-	0.6	

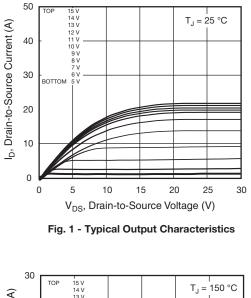
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•	•	•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2	-	4	V
	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-Source Leakage		-	$V_{GS} = \pm 30 \text{ V}$		-	± 1	μA
			$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	1	· ·
Zero Gate Voltage Drain Current	I _{DSS}		/, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 4 A$	-	0.82	-	Ω
Forward Transconductance	g _{fs}	V _{DS}	= 30 V, I _D = 4 A	-	16	-	S
Dynamic		[_]		1	1	1	1
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	1900	-	
Output Capacitance	C _{oss}	-	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$	-	400	-	
Reverse Transfer Capacitance	C _{rss}		f = 1 MHz	-	240	-	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	- V _{DS} = 0 V to 520 V, V _{GS} = 0 V		-	45	-	pF
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	62	-	
Total Gate Charge	Qg			-	40	57	+
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V I _D = 4 A, V _{DS} = 520 V		-	4.0	-	nC
Gate-Drain Charge	Q _{gd}			-	5.4	-	1
Turn-On Delay Time	t _{d(on)}			-	25	-	
Rise Time	t _r	$V_{DD} = 520 \text{ V}, \text{ I}_{D} = 4 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega$ $\text{f} = 1 \text{ MHz, open drain}$		-	55	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	70	-	
Fall Time	t _f			-	40	-	
Gate Input Resistance	Rg			-	3.5	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	7	
Pulsed Diode Forward Current	I _{SM}			-	-	18	A
Diode Forward Voltage	V _{SD}	T _{.1} = 25 °C, I _S = 4 A, V _{GS} = 0 V		-	-	1.5	V
Reverse Recovery Time	t _{rr}			-	190	-	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 2$	$5 ^{\circ}\text{C}, I_{\text{F}} = I_{\text{S}} = 4 \text{A},$	-	2.3	-	μC
Reverse Recovery Current	I _{RRM}	ai/dt = 1	100 A/µs, V _R = 400 V	_	10	_	A

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .







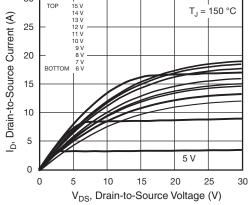


Fig. 2 - Typical Output Characteristics

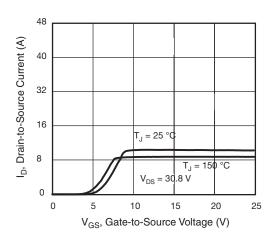


Fig. 3 - Typical Transfer Characteristics

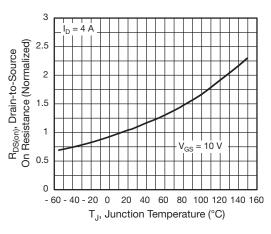


Fig. 4 - Normalized On-Resistance vs. Temperature

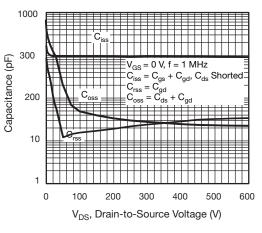


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

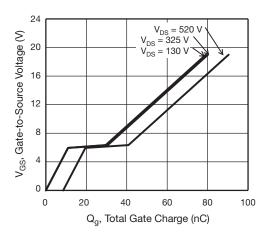


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



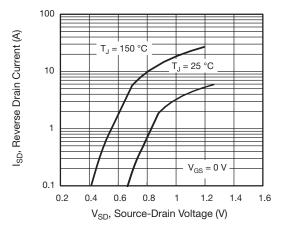


Fig. 7 - Typical Source-Drain Diode Forward Voltage

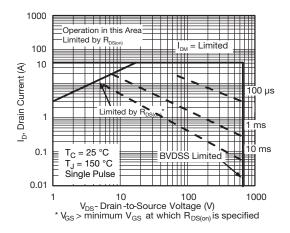


Fig. 8 - Maximum Safe Operating Area

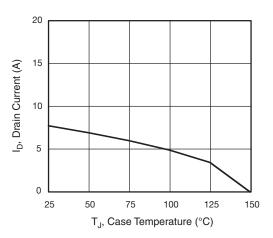


Fig. 9 - Maximum Drain Current vs. Case Temperature

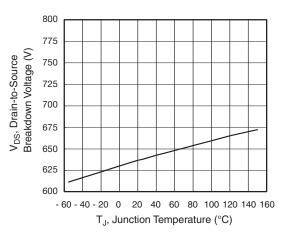


Fig. 10 - Temperature vs. Drain-to-Source Voltage

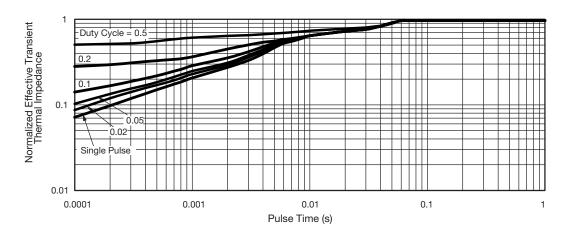


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



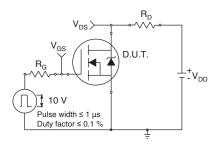


Fig. 12 - Switching Time Test Circuit

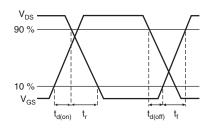


Fig. 13 - Switching Time Waveforms

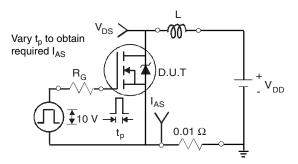


Fig. 14 - Unclamped Inductive Test Circuit

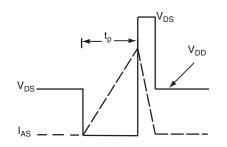


Fig. 15 - Unclamped Inductive Waveforms

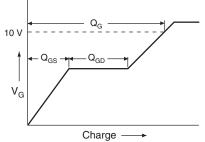


Fig. 16 - Basic Gate Charge Waveform

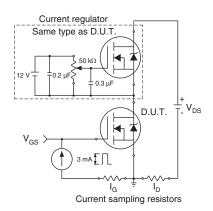
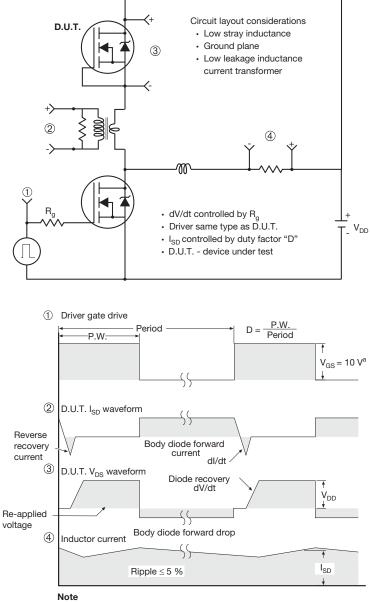


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

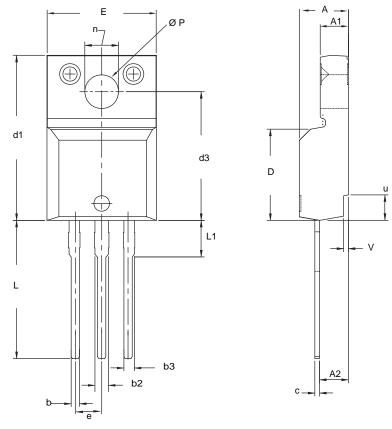


a. $V_{GS} = 5 V$ for logic level devices

Fig. 18 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



	MILLI	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness.

5. No chipping or package damage.

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